



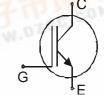
## IGBT Chip in NPT-technology

#### **FEATURES**:

- 600V NPT technology
- 100µm chip
- positive temperature coefficient
- · easy paralleling

### This chip is used for:

IGBT Modules



## Applications:

drives

Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code		
SIGC12T60NC	600V	10A	3.5 x 3.5 mm <sup>2</sup>	sawn on foil	Q67041-A4688- A001		

### **MECHANICAL PARAMETER:**

Raster size	3.5 x 3.5	mm²			
Area total / active	12.25 / 8.7				
Emitter pad size	1.989 x 1.583	17,50			
Gate pad size	1.1 x 0.694	C.COM			
Thickness	100	μm			
Wafer size	150	mm			
Flat position	0	deg			
Max.possible chips per wafer	1219				
Passivation frontside	Photoimide				
Emitter metallization	3200 nm Al Si 1%				
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	AI, ≤500μm				
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



#### **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T <sub>j</sub> =25 °C	V <sub>CE</sub>	600	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)	Α
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	30	Α
Gate-emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	$T_j$ , $T_{stg}$	-55 <b>+</b> 150	°C

<sup>1)</sup> depending on thermal properties of assembly

## **STATIC CHARACTERISTICS** (tested on chip), $T_j$ =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
Tarameter			min.	typ.	max.	
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{GE}$ =0V, $I_{C}$ =500 $\mu$ A	600			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =10A	1.6	2.0	2.5	٧
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_C$ =350 $\mu$ A, $V_{GE}$ = $V_{CE}$	4.5	5.5	6.5	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =600V, V <sub>GE</sub> =0V			0.8	μA
Gate-emitter leakage current	I <sub>GES</sub>	V <sub>CE</sub> =0V, V <sub>GE</sub> =20V			120	nA

### **DYNAMIC CHARACTERISTICS** (tested at component):

Parameter	Symbol	Conditions	Value			Unit
r ai ailletei			min.	typ.	max.	Joint
Input capacitance	Ciss	V <sub>CE</sub> =25V,	-	450	-	pF
Output capacitance	Coss	$V_{GE}=0V$ ,	-	tbd	-	
Reverse transfer capacitance	Crss	f=1MHz	-	40	-	

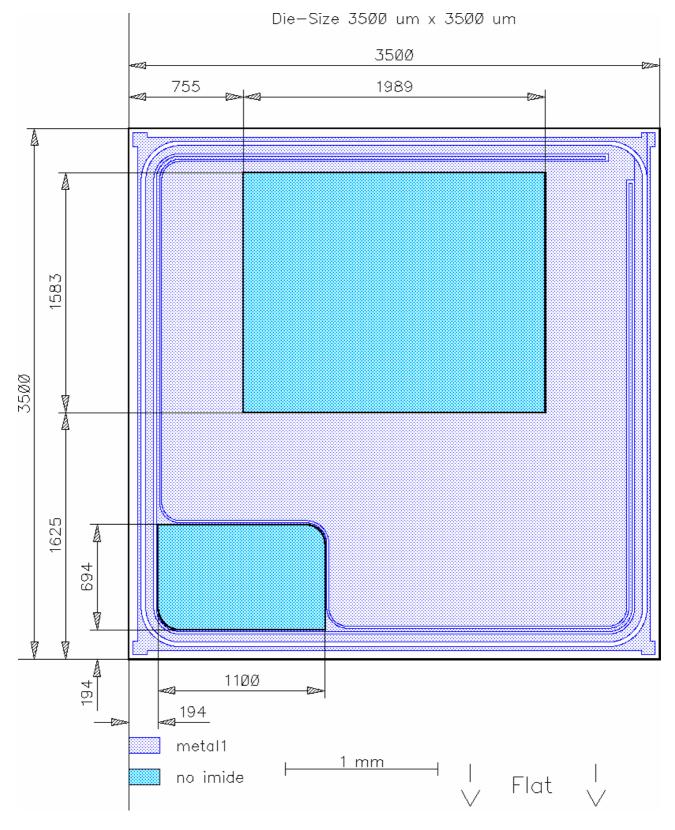
## SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

Parameter	Symbol	Conditions 1)	Value			Unit
			min.	typ.	max.	
Turn-on delay time	$t_{d(on)}$	$T_{\rm j}$ =125°C $V_{\rm CC}$ =300V	-	21	-	ns
Rise time	$t_{r}$	I <sub>C</sub> =10A	-	8	-	
Turn-off delay time	$t_{d(off)}$	$V_{\text{GE}} = \pm 15/V$ $R_{\text{G}} = 27\Omega$	-	110	-	
Fall time	$t_{f}$	716-2722	-	25	-	

<sup>&</sup>lt;sup>1)</sup> values also influenced by parasitic L- and C- in measurement and package.



### **CHIP DRAWING:**





#### **FURTHER ELECTRICAL CHARACTERISTICS:**

This chip data sheet refers to the device data sheet

FS 10 R06 XL4

#### **Description:**

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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